Sulfuric Acid 96% CMOS





Material No.: 9684-03 Batch No.: 0000012647 Manufactured Date: 2012/08/02 Retest Date: 2017/08/01

Certificate of Analysis

Test	Specification	Result
ssay (H2SO4)	95.0 - 97.0 %	96.5
olor (APHA)	<= 10	5
esidue after Ignition	<= 2 ppm	2
hloride (Cl)	<= 0.1 ppm	< 0.1
litrate (NO₃)	<= 0.2 ppm	< 0.1
hosphate (PO4)	<= 0.3 ppm	< 0.1
race Impurities – Aluminum (Al)	<= 50.0 ppb	7.0
rsenic and Antimony (as As)	<= 5 ppb	< 2
race Impurities – Barium (Ba)	<= 10.0 ppb	< 1.0
race Impurities – Beryllium (Be)	<= 10.0 ppb	< 1.0
race Impurities – Bismuth (Bi)	<= 20.0 ppb	< 10.0
race Impurities – Boron (B)	<= 10.0 ppb	< 5.0
race Impurities – Cadmium (Cd)	<= 10.0 ppb	< 1.0
race Impurities – Calcium (Ca)	<= 50.0 ppb	31.0
race Impurities – Chromium (Cr)	<= 50.0 ppb	< 1.0
race Impurities – Cobalt (Co)	<= 10.0 ppb	< 1.0
race Impurities – Copper (Cu)	<= 10.0 ppb	< 1.0
race Impurities – Gallium (Ga)	<= 10.0 ppb	< 1.0
race Impurities – Germanium (Ge)	<= 10.0 ppb	< 10.0
race Impurities – Gold (Au)	<= 20.0 ppb	< 5.0
leavy Metals (as Pb)	<= 200 ppb	< 100
race Impurities – Iron (Fe)	<= 100.0 ppb	12.0
race Impurities – Lead (Pb)	<= 20.0 ppb	< 1.0
race Impurities – Lithium (Li)	<= 10.0 ppb	< 1.0

For questions on this Certificate of Analysis please contact Technical Services at 855.282.6867 or +1.610.573.2600 Avantor ™ Performance Materials Inc.

3477 Corporate Parkway. Suite #200. Center Valley, PA 18034. U.S.A. Phone: 610.573.2600 . Fax: 610.573.2610

Test	Specification	Result
race Impurities – Magnesium (Mg)	<= 50.0 ppb	2.0
race Impurities – Manganese (Mn)	<= 10.0 ppb	< 1.0
race Impurities – Mercury (Hg)	<= 5.0 ppb	< 0.1
race Impurities – Molybdenum (Mo)	<= 10.0 ppb	< 5.0
race Impurities – Nickel (Ni)	<= 10.0 ppb	< 5.0
race Impurities – Niobium (Nb)	<= 10.0 ppb	< 1.0
race Impurities – Potassium (K)	<= 50.0 ppb	< 10.0
race Impurities – Silicon (Si)	<= 50.0 ppb	< 10.0
race Impurities – Silver (Ag)	<= 10.0 ppb	< 1.0
race Impurities – Sodium (Na)	<= 100.0 ppb	23.0
race Impurities – Strontium (Sr)	<= 10.0 ppb	< 1.0
race Impurities – Tantalum (Ta)	<= 10.0 ppb	< 5.0
race Impurities – Thallium (Tl)	<= 20.0 ppb	< 5.0
race Impurities – Tin (Sn)	<= 50.0 ppb	< 1.0
race Impurities – Titanium (Ti)	<= 10.0 ppb	10.0
race Impurities – Vanadium (V)	<= 10.0 ppb	< 1.0
race Impurities – Zinc (Zn)	<= 50.0 ppb	4.0
race Impurities – Zirconium (Zr)	<= 10.0 ppb	< 1.0
article Count – 0.5 µm and greater	<= 60 par/ml	35
Particle Count - 1.0 µm and greater	<= 10 par/ml	9

For Microelectronic Use

Storage Conditions:Recommended Storage Conditions: 15° - 100°FCountry of Origin:USPackaging Site:Paris Mfg Ctr & DC



Phillipsburg, NJ 9001:2008, 14001:2004 Paris, KY 9001:2008 Mexico City, Mexico 9001:2008 Deventer, The Netherlands 9001:2008, 14001:2004, 13485:2003 Gliwice, Poland 9001:2008, 17025:2005 Selangor, Malaysia 9001:2008 Dehradun, India, 9001:2008, 14001:2004, 13485:2003 Mumbai, India, 9001:2008, 17025:2005 Panoli, India 9001:2008

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Richard M Siberski Global Director of Quality Assurance

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